

L Number	Hits	Search Text	DB	Time stamp
1	25	(((silicon with oxide) with (impurity with (prevention reduction))) and (((438/\$) (257/\$)).ccls.)) and @ad<=19960229	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/12 10:41
2	5	((("5863702") or ("5960321") or ("6071810") or ("6136686") or ("6153519")).PN.	USPAT; US-PGPUB	2003/12/12 10:42
-	1	("5192697").PN.	USPAT	2002/07/12 13:22
-	1	("5192697").PN.	USPAT	2002/02/12 13:58
-	1	("5192697").PN.	USPAT	2002/02/12 14:35
-	2	("4983546"   "5003062").PN.	USPAT	2002/02/12 13:58
-	38	((ion adj implantation) (doping) ) with ((spin adj on adj glass) sog)	USPAT	2002/07/30 13:56
-	5	(((ion adj implantation) (doping) ) with ((spin adj on adj glass) sog)) and @ad<=19920127	USPAT	2002/02/12 15:02
-	75	((ion adj implantation) (doping) ) with ((spin adj on adj glass) sog)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/02/12 15:03
-	5	(((ion adj implantation) (doping) ) with ((spin adj on adj glass) sog)) and @ad<=19920127	USPAT	2002/02/12 15:02
-	2	(((ion adj implantation) (doping) ) with ((spin adj on adj glass) sog)) and (ion with prevention)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/02/13 08:15
-	8	("4668973"   "4676867"   "5310700"   "5341026"   "5373192"   "5387812"   "5519254"   "5523616").PN.	USPAT	2002/02/12 15:04
-	0	305056.URPN.	USPAT; US-PGPUB; EPO; JPO; DERWENT	2002/02/13 08:13
-	62	(((ion adj implantation) (doping) ) with ((spin adj on adj glass) sog)) and (ion)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/02/13 08:17
-	5	(((ion adj implantation) (doping) ) with ((spin adj on adj glass) sog)) and (ion)) and spacer	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/02/13 11:08
-	5	((((ion adj implantation) (doping) ) with ((spin adj on adj glass) sog)) and (ion)) and spacer) and @ad<=19990111	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/02/13 11:12
-	9	((((ion adj implantation) (doping) ) with ((spin adj on adj glass) sog)) and (ion)) and (spacer sidewall)) and @ad<=19990111	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/02/13 11:12
-	10	("5429990"   "5457073"   "5472825"   "5496776"   "5607880"   "5883001"   "5892269"   "5893750"   "5898221"   "5932487").PN.	USPAT	2002/02/13 11:28
-	2	((("5192697") or ("6001745")).PN.	USPAT	2002/02/14 08:02
-	13	((("4906594") or ("4882300") or ("5635763") or ("5892269") or ("5895265") or ("5898221") or ("6008141") or ("6288438") or ("6214749") or ("6071807") or ("6150725") or ("6235648") or ("6177343")).PN.	USPAT	2002/07/12 09:28
-	2728	((438/758) or (438/761) or (438/780) or (438/781) or (438/782) or (438/783) or (438/787) or (438/789) or (438/794) or (257/751) or (257/759) or (257/760)).CCLS.	USPAT	2002/07/12 13:23

-	1067	((438/758) or (438/761) or (438/780) or (438/781) or (438/782) or (438/783) or (438/787) or (438/789) or (438/794) or (257/751) or (257/759) or (257/760)).CCLS.) and @ad<=19960229	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/07/15 08:07
-	1	((438/758) or (438/761) or (438/780) or (438/781) or (438/782) or (438/783) or (438/787) or (438/789) or (438/794) or (257/751) or (257/759) or (257/760)).CCLS.) and @ad<=19960229 and ((spin adj on adj glass) sog) and ((argon ar) with (implantation doping))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/07/12 14:21
-	2	("4983546"   "5003062").PN.	USPAT	2002/07/12 13:55
-	23	5192697.URPN.	USPAT	2002/07/12 13:56
-	17	5429990.URPN.	USPAT	2002/07/12 14:00
-	10	("5429990"   "5457073"   "5472825"   "5496776"   "5607880"   "5883001"   "5892269"   "5893750"   "5898221"   "5932487").PN.	USPAT	2002/07/12 14:10
-	10	("5429990"   "5457073"   "5472825"   "5496776"   "5607880"   "5883001"   "5892269"   "5893750"   "5898221"   "5932487").PN.	USPAT	2002/07/12 14:10
-	8	("4668973"   "4676867"   "5310700"   "5341026"   "5373192"   "5387812"   "5519254"   "5523616").PN.	USPAT	2002/07/12 14:16
-	6	5892269.URPN.	USPAT	2002/07/12 14:20
-	20	("4962052"   "4984055"   "5186745"   "5192697"   "5270259"   "5314834"   "5404046"   "5468684"   "5496776"   "5569618"   "5581101"   "5786273"   "5817582"   "5855962"   "5892269"   "5898221"   "5930624"   "5963827"   "6013578"   "6071807").PN.	USPAT	2002/07/12 14:20
-	9	((438/758) or (438/761) or (438/780) or (438/781) or (438/782) or (438/783) or (438/787) or (438/789) or (438/794) or (257/751) or (257/759) or (257/760)).CCLS.) and @ad<=19960229 and (silicon adj oxide) and ((plasma adj enhanced adj chemical adj vapor adj deposition) pecvd cvd) and (intrusion impurity) and (prevention)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/07/12 14:33
-	4	((438/758) or (438/761) or (438/780) or (438/781) or (438/782) or (438/783) or (438/787) or (438/789) or (438/794) or (257/751) or (257/759) or (257/760)).CCLS.) and @ad<=19960229 and (silicon adj oxide) with ((plasma adj enhanced adj chemical adj vapor adj deposition) pecvd cvd) and (intrusion impurity) and (prevention)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/07/12 14:33
-	4	((438/758) or (438/761) or (438/780) or (438/781) or (438/782) or (438/783) or (438/787) or (438/789) or (438/794) or (257/751) or (257/759) or (257/760)).CCLS.) and @ad<=19960229 and ((silicon adj oxide) "si.sub.o2") with ((plasma adj enhanced adj chemical adj vapor adj deposition) pecvd cvd) and (intrusion impurity) and (prevention)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/07/12 14:34
-	17	5376590.URPN.	USPAT	2002/07/12 14:40
-	6	("4371587"   "4851370"   "4870475"   "4883766"   "4962063"   "5057897").PN.	USPAT	2002/07/12 14:50
-	6	("4371587"   "4851370"   "4870475"   "4883766"   "4962063"   "5057897").PN.	USPAT	2002/07/15 08:06
-	2	("6001745").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/07/15 08:06
-	2039	((438/758) or (438/761) or (438/780) or (438/781) or (438/782) or (438/783) or (438/787) or (438/789) or (438/794) or (257/751) or (257/759) or (257/760)).CCLS.) and @ad<=19960229	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/14 10:32

-	1	(((((438/758) or (438/761) or (438/780) or (438/781) or (438/782) or (438/783) or (438/787) or (438/789) or (438/794) or (257/751) or (257/759) or (257/760)).CCLS.) and @ad<=19960229) and contamination with prevention	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/14 10:33
-	28	(((((438/758) or (438/761) or (438/780) or (438/781) or (438/782) or (438/783) or (438/787) or (438/789) or (438/794) or (257/751) or (257/759) or (257/760)).CCLS.) and @ad<=19960229) and (impurities contamination degradation) with (prevention protection)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/14 10:33
-	81	(silicon with oxide) with (impurity with (prevention reduction)))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/14 10:34
-	37	((silicon with oxide) with (impurity with (prevention reduction))) and (((438/\$) (257/\$)).ccls.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/14 10:34
-	25	((silicon with oxide) with (impurity with (prevention reduction))) and (((438/\$) (257/\$)).ccls.)) and @ad<=19960229	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/14 10:34
-	5	("5818068" or "6001745").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/14 10:29
-	2048	(((((438/758) or (438/761) or (438/780) or (438/781) or (438/782) or (438/783) or (438/787) or (438/789) or (438/794) or (257/751) or (257/759) or (257/760)).CCLS.) and @ad<=19960229	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/14 10:32
-	1	(((((438/758) or (438/761) or (438/780) or (438/781) or (438/782) or (438/783) or (438/787) or (438/789) or (438/794) or (257/751) or (257/759) or (257/760)).CCLS.) and @ad<=19960229) and contamination with prevention	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/14 10:33
-	28	(((((438/758) or (438/761) or (438/780) or (438/781) or (438/782) or (438/783) or (438/787) or (438/789) or (438/794) or (257/751) or (257/759) or (257/760)).CCLS.) and @ad<=19960229) and (impurities contamination degradation) with (prevention protection)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/14 10:33
-	83	(silicon with oxide) with (impurity with (prevention reduction)))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/14 10:34
-	42	((silicon with oxide) with (impurity with (prevention reduction))) and (((438/\$) (257/\$)).ccls.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/14 10:35
-	25	((silicon with oxide) with (impurity with (prevention reduction))) and (((438/\$) (257/\$)).ccls.)) and @ad<=19960229	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/12 10:41
-	3	("5192697"   "5328871"   "5459105").PN.	USPAT	2003/12/04 11:09